

# MCR8DSM, MCR8DSN



# Description

Designed for high volume, low cost, industrial and consumer applications such as motor control; process control; temperature, light and speed control.

# Features

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Available in Two Package Styles Surface Mount Lead Form – Case 369C Miniature Plastic Package – Straight Leads – Case 369
- Epoxy Meets UL 94 V-0 @ 0.125 in

Po

- ESD Ratings: Human Body Model, 3B > 8000 V Machine Model, C > 400V
- Pb–Free Packages are Available

# Pin Out



# **Functional Diagram**



# **Additional Information**







Samples



| Maximum Ratings ( | T <sub>j</sub> = 25°C unless otherwise noted) |
|-------------------|---|
|-------------------|---|

| Rating   |                    | Symbol                                 | Value      | Unit               |
|--|--------------------|--|------------|--------------------|
| Peak Repetitive Off-State Voltage (Note 1)<br>(T <sub>J</sub> =-40 to 110°C, Sine Wave, 50 to 60 Hz) | MCR8DSM<br>MCR8DSN | V <sub>drm</sub> ,<br>V <sub>rrm</sub> | 600<br>800 | V                  |
| On-State RMS Current (180° Conduction Angles; $T_c = 90$ °C)   |                    | I <sub>T (RMS)</sub>                   | 8.0        | A                  |
| Average On–State Current (180° Conduction Angles; $T_c = 90$ °C)                                     |                    | I <sub>T(AV)</sub>                     | 5.1        | А                  |
| Peak Non-Repetitive Surge Current<br>(1/2 Cycle, Sine Wave 60 Hz, T <sub>J</sub> = 110°C)            |                    | I <sub>TSM</sub>                       | 90         | А                  |
| Circuit Fusing Consideration (t = 8.3 ms)  |                    | l²t                                    | 34         | A <sup>2</sup> sec |
| Forward Peak Gate Power (Pulse Width $\leq$ 10 $\mu sec, T_{_{\rm C}}$ = 90°C)                       |                    | P <sub>GM</sub>                        | 5.0        | W                  |
| Forward Average Gate Power (t = 8.3 msec, $T_c = 90^{\circ}C$ )                                      |                    | P <sub>GM (AV)</sub>                   | 0.5        | W                  |
| Forward Peak Gate Current (Pulse Width $\leq$ 10 µsec, T <sub>c</sub> = 90°C)                        |                    | I <sub>GM</sub>                        | 2.0        | А                  |
| Operating Junction Temperature Range   |                    | Tj                                     | -40 to 110 | °C                 |
| Storage Temperature Range  |                    | T <sub>stg</sub>                       | -40 to 150 | °C                 |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

| Thermal Characteristics   |                  |       |      |  |  |  |
|---|------------------|-------|------|--|--|--|
| Rating  | Symbol           | Value | Unit |  |  |  |
| Thermal Resistance, Junction-to-Case  | R <sub>euc</sub> | 2.2   |      |  |  |  |
| Thermal Resistance, Junction-to-Ambient                                       | R <sub>eja</sub> | 88    | °C/W |  |  |  |
| Thermal Resistance, Junction-to-Ambient (Note 2)                              | R <sub>eja</sub> | 80    | -    |  |  |  |
| Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds | TL               | 260   | °C   |  |  |  |

# Electrical Characteristics - OFF (T<sub>1</sub> = 25°C unless otherwise noted)

|   |                        | Construct          | N.4.: | Tur | Maria | 11   |
|---|------------------------|--------------------|-------|-----|-------|------|
| Characteristic  |                        | Symbol             | Min   | Тур | Max   | Unit |
| Peak Repetitive Forward or Reverse Blocking Current (Note 3)        | $T_{J} = 25^{\circ}C$  | I <sub>DRM</sub> , | -     | -   | 10    |      |
| (V_{AK} = Rated V_{DRM} \text{ or } V_{RRM'}  R_{GK} = 1.0  k\Omega | $T_{J} = 110^{\circ}C$ | I <sub>RRM</sub>   | -     | -   | 500   | μΑ   |

**Electrical Characteristics** - **ON** ( $T_1 = 25^{\circ}C$  unless otherwise noted; Electricals apply in both directions)

| Characteristic   |   | Symbol           | Min         | Тур            | Max             | Unit |
|--|---|------------------|-------------|----------------|-----------------|------|
| Peak Reverse Gate Blocking Voltage (I $_{_{GR}}$ = 10 $\mu A)$   |   | V <sub>grm</sub> | 10          | 12.5           | 18              | V    |
| Peak Reverse Gate Blocking Current ( $V_{gR} = 10 \text{ V}$ )   |   | I <sub>RGM</sub> | _           | -              | 1.2             | μA   |
| Peak Forward On–State Voltage (Note 4) ( $I_{TM} = 16 \text{ A}$ )   |   | V <sub>TM</sub>  | -           | 1.4            | 1.8             | V    |
| Gate Trigger Current (Continuous dc) (Note 5) (V <sub>AK</sub> = 12 Vdc, R <sub>L</sub> = 100 $\Omega$ )   | $(T_{J} = 25^{\circ}C)$<br>$(T_{J} = -40^{\circ}C)$                             | I <sub>GT</sub>  | 5.0<br>—    | 12             | 200<br>300      | μA   |
| Gate Trigger Voltage (Continuous dc) ( $V_{\rm D}$ = 12 V, $R_{\rm L}$ = 100 $\Omega$ ) (Note 5)   | $(T_{J} = 25^{\circ}C)$<br>$(T_{J} = -40^{\circ}C)$<br>$(T_{J} = 110^{\circ}C)$ | V <sub>gt</sub>  | 0.45<br>0.2 | 0.65<br>-<br>- | 1.0<br>1.5<br>- | V    |
| Holding Current (V_{_{D}} = 12 V, Initiating Current = 200 mA, R_{_{GK}} = 1 k\Omega)  | $(T_{J} = 25^{\circ}C)$<br>$(T_{J} = -40^{\circ}C)$                             | I <sub>H</sub>   | 0.5<br>—    | 1.0            | 6.0<br>10       | mA   |
| Latching Current ( $V_{_{D}}$ = 12 V, IG = 2.0 mA, R <sub>GK</sub> = 1 kΩ)   | $(T_{J} = 25^{\circ}C)$<br>$(T_{J} = -40^{\circ}C)$                             | I <sub>L</sub>   | 0.5<br>-    | 1.0<br>-       | 6.0<br>10       | mA   |
| Total Turn–On Time<br>(Source Voltage = 12 V, $R_s = 6.0 \text{ k}\Omega$ , IT = 16 A(pk), $R_{gK} = 1.0 \text{ k}$<br>Rise Time = 20 ns, Pulse Width = 10 µs) | $\langle \Omega \rangle$ (VD = Rated V <sub>DRM</sub> ,                         | tgt              | _           | 2.0            | 5.0             | μs   |



| Dynamic Characteristics  |        |     |     |     |      |
|--|--------|-----|-----|-----|------|
| Characteristic   | Symbol | Min | Тур | Мах | Unit |
| Critical Rate of Rise of Off–State Voltage<br>( $V_D = 0.67 \text{ X}$ Rated $V_{DRM'}$ Exponential Waveform, $R_{GK} = 1.0 \text{ k}\Omega$ , $T_J = 110^{\circ}\text{C}$ ) | dv/dt  | 2.0 | 10  | -   | V/µs |

2. Surface mounted on minimum recommended pad size.

3. Ratings apply for negative gate voltage or RGK = 1.0 kQ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.

4. Pulse Test; Pulse Width  $\leq$  2.0 msec, Duty Cycle  $\leq$  2%.

5. RGK current not included in measurements.

# Voltage Current Characteristic of SCR

| Symbol           | Parameter                                 |
|------------------|---|
| V <sub>DRM</sub> | Peak Repetitive Forward Off State Voltage |
| I <sub>DRM</sub> | Peak Forward Blocking Current             |
| V <sub>RRM</sub> | Peak Repetitive Reverse Off State Voltage |
| I <sub>RRM</sub> | Peak Reverse Blocking Current             |
| V <sub>TM</sub>  | Maximum On State Voltage                  |
| I <sub>H</sub>   | Holding Current                           |





#### Figure 2. On-State Power Dissipation





# Figure 3. On–State Characteristics



#### Figure 4. Transient Thermal Response



#### Figure 5. Typical Gate Trigger Current vs Junction Temperature 1000 GT, GATE TRIGGER CURRENT ( µA) $R_{GK} = 1.0 \text{ K}\Omega$ 100 GATE OPEN 10 1.0 **2**5 40 **1**0 50 20 35 50 65 80 95 110

Figure 6. Typical Gate Trigger Voltage vs Junction Temperature



# Figure 8. Typical Latching Current vs Junction Temperature



# Figure 7. Typical Holding Current vs Junction Temperature

TJ, JUNCTION TEMPERATURE (C)





# Figure 9. Holding Current versus Gate–Cathode Resistance

# Figure 10. Exponential Static dv/dt vs Gate–Cathode Resistance and Junction Temperature

# Figure 11. Exponential Static dv/dt vs Gate–Cathode Resistance and Peak Voltage



#### Figure 12. Exponential Static dv/dt vs Gate–Cathode Resistance and Gate Trigger Current Sensitivity





# Dimensions



| 5.  | Inches |            | Millin | neters |
|-----|--------|------------|--------|--------|
| Dim | Min    | Мах        | Min    | Мах    |
| Α   | 0.087  | 0.094      | 2.20   | 2.40   |
| A1  | 0.000  | 0.005      | 0.00   | 0.12   |
| b   | 0.022  | 0.030      | 0.55   | 0.75   |
| b2  | 0.026  | 0.033      | 0.65   | 0.85   |
| b3  | 0.209  | 0.217      | 5.30   | 5.50   |
| C   | 0.019  | 0.023      | 0.49   | 0.59   |
| c2  | 0.019  | 0.023      | 0.49   | 0.59   |
| D   | 0.213  | 0.224      | 5.40   | 5.70   |
| E   | 0.252  | 0.260      | 6.40   | 6.60   |
| е   | 0.091  |            | 2.3    | 30     |
| н   | 0.374  | 0.406      | 9.50   | 10.30  |
| L   | 0.058  | 0.070      | 1.47   | 1.78   |
| L1  | 0.114  |            | 2.90   |        |
| L2  | 0.0    | )20        | 0.     | 51     |
| L3  | 0.053  | 0.065 1.35 |        | 1.65   |
| L4  | 0.028  | 0.039      | 0.70   | 1.00   |
| Z   | 0.154  | -          | 3.90   | -      |

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.



4. MT2

# **Soldering Footprint**



# Part Marking System



| Pin Assignment |         |  |  |  |
|----------------|---------|--|--|--|
| 1              | Cathode |  |  |  |
| 2              | Anode   |  |  |  |
| 3              | Gate    |  |  |  |
| 4              | Anode   |  |  |  |

| Ordering Information |                   |                  |  |  |  |
|----------------------|-------------------|------------------|--|--|--|
| Device               | Package           | Shipping         |  |  |  |
| MCR8DSMT4            | DPAK              |                  |  |  |  |
| MCR8DSMT4G           | DPAK<br>(Pb–Free) | 2500/Tape & Reel |  |  |  |
| MCR8DSNT4            | DPAK              |                  |  |  |  |
| MCR8DSNT4G           | DPAK<br>(Pb–Free) |                  |  |  |  |

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